



认证证书

兹证明

无锡西佩意电子有限公司

统一社会信用代码: 91320200783385364A

中国江苏省无锡市南长区南湖大道 503-5-101/201 214000

经 NSF-ISR 评估, 已建立的质量管理体系符合国际质量体系标准:

ISO 9001:2015

认证范围:

通信电缆组件及线束的生产

删减: 产品设计



证书编号:
证书颁发日期:
注册日期:
证书到期日期*:

CNQMS050951
2021/12/20
2021/12/20
2024/12/19

Jennifer Morecraft,
Global Managing Director

本证书信息可在国家认证认可监督管理委员会官方网站 (www.cnca.gov.cn) 上查询
获证组织必须定期接受监督审核并经审核合格此证书方继续有效

NSF International Strategic Registrations

789 North Dixboro Road, Ann Arbor, Michigan 48105 | (888) NSF-9000 | www.nsf-isr.org

Authorized Registration and/or Accreditation Marks. This certificate is property of NSF-ISR and must be returned upon request.
*Company is audited for conformance at regular intervals. To verify registrations call (888) NSF-9000 or visit our web site at www.nsf-isr.org



Certificate of Registration

This certifies that the Quality Management System of

Wuxi CPE Electronics Co., Ltd.

Unified Social Credit Code: 91320200783385364A

503-5-101/201, Nanhu Avenue, Nanchang District,

Wuxi City, Jiangsu Province, China 214000

has been assessed by NSF-ISR and found to be in conformance to the following standards(s):

ISO 9001:2015

Scope of Registration:

Manufacturing of communication cable assembly and harness

Exclusions: Product Design

Certificate Number:

CNQMS050951

Certificate Issue Date:

20-DEC-2021

Registration Date:

20-DEC-2021

Expiration Date*:

19-DEC-2024

Jennifer Morecraft,
Global Managing Director



The certificate information can be searched on the website of CNCA (www.cnca.gov.cn).

The certified organization must do the regular surveillance audit and get valid audit conclusion to maintain the effective of the certificate

NSF International Strategic Registrations

789 North Dixboro Road, Ann Arbor, Michigan 48105 | (888) NSF-9000 | www.nsf-isr.org

Authorized Registration and/or Accreditation Marks: This certificate is property of NSF-ISR and must be returned upon request.

*Company is audited for conformance at regular intervals. To verify registrations call (888) NSF-9000 or visit our web site at www.nsf-isr.org